459 **\$0C32/80C52/87C52** 

#### **DESCRIPTION**

The Philips 80C32/80C52/87C52 is a high-performance microcontroller fabricated with Philips high-density CMOS technology. The CMOS 8XC52 is functionally compatible with the NMOS SCN- 8032/8052 microcontrollers. The Philips CMOS technology combines the high speed and density characteristics of HMOS with the low power attributes of CMOS. Philips epitaxial substrate minimizes latch-up sensitivity.

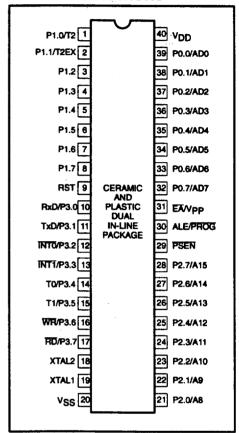
The 8XC52 contains an  $8k \times 8$  ROM (80C52) EPROM (87C52), a 256  $\times$  8 RAM, 32 I/O lines, three 16-bit counter/timers, a six-source, two-priority level nested interrupt structure, a serial I/O port for either multi-processor communications, I/O expansion or full duplex UART, and on-chip oscillator and clock circuits.

In addition, the 8XC52 has two software selectable modes of power reduction—idle mode and power-down mode. The idle mode freezes the CPU while allowing the RAM, timers, serial port, and interrupt system to continue functioning. The power-down mode saves the RAM contents but freezes the oscillator, causing all other chip functions to be inoperative.

#### **FEATURES**

- 80C51 based architecture
- 8032/8052 compatible
- 8k × 8 ROM (80C52)
- 8k × 8 EPROM (87C52)
- ROMIess (80C32)
- 256 × 8 RAM
- Three 16-bit counter/timers
- Full duplex serial channel
- Boolean processor
- Memory addressing capability
  - 64k ROM and 64k RAM
- Power control modes:
- Idle mode
- Power-down mode
- CMOS and TTL compatible
- Two speed ranges:
  - 3.5 to 16MHz
  - 3.5 to 24MHz
- Five package styles
- Extended temperature ranges
- OTP package available

#### PIN CONFIGURATIONS



#### **ORDERING INFORMATION**

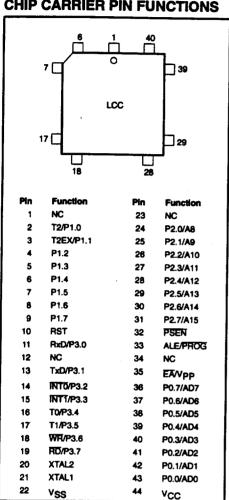
ROMiess ROM		EPROM		TEMPERATURE RANGE °C AND PACKAGE <sup>1</sup>	FREQ MHz	DRAWING NUMBER
P80C32EBP N	P80C52EBP N	P87C52EBP N	OTP	0 to +70, Plastic Dual In-line Package	16	0415C
P80C32EBA A	P80C52EBA A	P87C52EBA A	OTP	0 to +70, Plastic Leaded Chip Carrier	16	0403G
		P87C52EBF FA	UV	0 to +70, Ceramic Dual In-line Package	16	0590B
		P87C52EBL KA	UV	0 to +70, Ceramic Leaded Chip Carrier	16	1472A
P80C32EBB B	P80C52EBB B	P87C52EBB B	OTP	0 to +70, Plastic Quad Flat Pack	16	1118D
P80C32EFP N	P80C52EFP N	P87C52EFP N	OTP	-40 to +85, Plastic Dual In-line Package	16	0415C
P80C32EFA A	P80C52EFA A	P87C52EFA A	OTP	-40 to +85, Plastic Leaded Chip Carrier	16	0403G
		P87C52EFF FA	UV	-40 to +85, Ceramic Dual In-line Package	16	0590B
		P87C52EFL KA	UV	40 to +85, Ceramic Leaded Chip Carrier	16	1472A
P80C32EFB B	P80C52EFB B	P87C52EFB B	OTP	-40 to +85, Plastic Quad Flat Pack	16	1118D
P80C32IBP N	P80C52IBP N	P87C52IBP N	OTP	0 to +70, Plastic Dual In-line Package	24	0415C
P80C32IBA A	P80C52IBA A	P87C52IBA A	ОТР	0 to +70, Plastic Leaded Chip Carrier	24	0403G
		P87C52IBF FA	UV	0 to +70, Ceramic Dual In-line Package	24	0590B
		P87C52IBL KA	UV	0 to +70, Ceramic Leaded Chip Carrier	24	1472A
P80C32IFP N	P80C52IFP N	P87C52IFP N	ОТР	-40 to +85, Plastic Dual In-line Package	24	0415C
P80C32IFA A	P80C52IFA A	P87C52IFA A	OTP	-40 to +85, Plastic Leaded Chip Carrier	24	0403G
		P87C52IFF FA	UV	-40 to +85, Ceramic Dual In-line Package	24	0590B
		P87C52IFL KA	UV	-40 to +85, Ceramic Leaded Chip Carrier	24	1472A

#### NOTE:

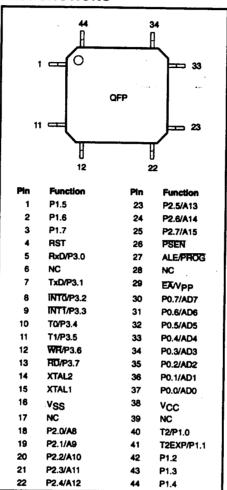
1. OTP = One Time Programmable EPROM. UV = UV erasable EPROM

### 80C32/80C52/87C52

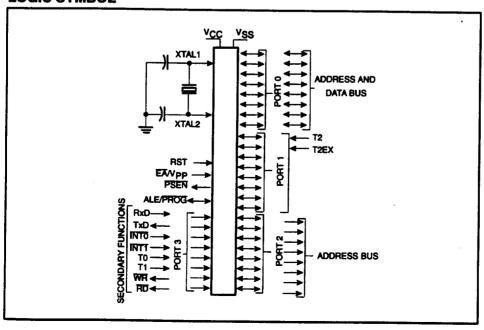
# CERAMIC AND PLASTIC LEADED CHIP CARRIER PIN FUNCTIONS



# PLASTIC QUAD FLAT PACK PIN FUNCTIONS

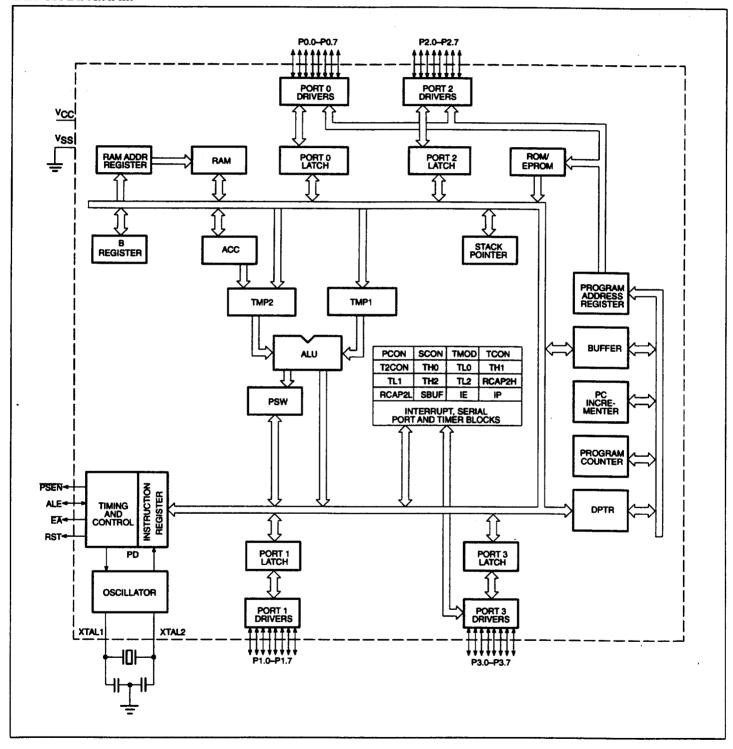


### **LOGIC SYMBOL**



### 80C32/80C52/87C52

### **BLOCK DIAGRAM**



### 80C32/80C52/87C52

Table 1. 8XC52 Special Function Registers

SYMBOL	DESCRIPTION	DIRECT ADDRESS	BIT MSB	ADDRE	SS, SYMI	BOL, OR	ALTERNA	TIVE POI	RT FUNC	TION LSB	RESET VALUE
ACC*	Accumulator	E0H	E7	E6	<b>E</b> 5	E4	E3	E2	E1	E0	00H
B*	B register	FOH	F7	F6	F5	F4	F3	F2	F1	F0	00H
DPTR: DPH DPL	Data pointer (2 bytes) Data pointer high Data pointer low	83H 82H									00H 00H
			AF	AE	AD	AC	AB	AA	<b>A</b> 9	A8	
IE*	Interrupt enable	A8H	EA	_	ET2	ES	ET1	EX1	ET0	EX0	0x000000E
			BF	BE	BD	ВС	BB	BA	B9	B8	
IP*	Interrupt priority	В8Н	_	<u> </u>	PT2	PS	PT1	PX1	PT0	PX0	xx000000B
			87	86	85	84	83	82	81	80	
P0*	Port 0	80H	AD7	AD6	AD5	AD4	AD3	AD2	AD1	AD0	FFH
			97	96	95	94	93	92	91	90	
P1*	Port 1	90H		-	-	_	_	T -	T2EX	T2	FFH
					•	• ···		<u> </u>	<u> </u>		
			A7	A6	<b>A</b> 5	A4	A3	A2	A1	A0	
P2*	Port 2	A0H	A15	A14	A13	A12	A11	A10	A9	A8	FFH
			B7	<b>B</b> 6	B5	В4	В3	B2	B1	В0	
P3*	Port 3	вон	RD	WR	T1	T0	INT1	INTO	TxD	RxD	FFH
PCON1	Power control	87H	SMOD	-	_	-	GF1	GF0	PD	IDL	0xxxxxxxB
		ĺ			5.5	5.4					
PSW*	Program status word	DOH	D7 CY	D6	D5	D4	D3	D2	D1	D0	
RCAP2H#	Capture high	CBH	CY	AC	F0	RS1	RS0	ov	<u> </u>	Р	00H
RCAPL#	Capture low	CAH			-						00H
SBUF	Serial data buffer	99H									xxxxxxxxB
			9F	9E	9D	9C	9B	9A	99	98	
SCON*	Serial controller	98H	SM0	SM1	SM2	REN	TB8	RB8	TI	RI	00H
SP	Stack pointer	81H	8F	8E	8D	8C	8B	8A	89	88	07H
TCON*	Timer control	88H	TF1	TR1	TF0	TR0	IE1	IT1	IE0	ITO	00H
									<b>L</b>		
T2CON*#	Timer 2 control	C8H	CF TF2	CE EXF2	CD RCLK	CC TCLK	CB EXEN2	CA TR2	C9 C/T2	C8 CP/RL2	00H
TH0 TH1 TH2# TL0 TL1 TL2#	Timer high 0 Timer high 1 Timer high 2 Timer low 0 Timer low 1 Timer low 2	8CH 8DH CDH 8AH 8BH CCH					mr tool Va			OI TILL	00H 00H 00H 00H 00H
TMOD Bit address	Timer mode	89H	GATE	C/T	M1	M0	GATE	C/T	M1	MO	00H

<sup>#</sup> SFRs are modified from or added to the 80C51 SFRs.

<sup>1.</sup> Bits GF1, GF0, PD, and IDL of the PCON register are not implemented in the NMOS 8XC52.

## 80C32/80C52/87C52

### **PIN DESCRIPTION**

PIN NO.			Γ · · · ·					
MNEMONIC	DIP	LCC	QFP	TYPE	NAME AND FUNCTION			
V <sub>SS</sub>	20	22	16	1	Ground: 0V reference.			
Vcc	40	44	38	I	<b>Power Supply:</b> This is the power supply voltage for normal, idle, and power-down operation.			
P0.0-0.7	39–32	43–36	37–30	1/0	<b>Port 0:</b> Port 0 is an open-drain, bidirectional I/O port. Port 0 pins that have 1s written to them float and can be used as high-impedance inputs. Port 0 is also the multiplexed low-order address and data bus during accesses to external program and data memory. In this application, it uses strong internal pull-ups when emitting 1s. Port 0 also outputs the code bytes during program verification in the 87C52. External pull-ups are required during program verification.			
P1.0-P1.7	1–8	2–9	40–44 1–3	I/O	Port 1: Port 1 is an 8-bit bidirectional I/O port with internal pull-ups. Port 1 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 1 pins that are externally pulled low will source current because of the internal pull-ups. (See DC Electrical Characteristics: I <sub>IL</sub> ). Pins P1.0 and P1.1 also. Port 1 also receives the low-order address byte during program memory verification. Port 1 also serves alternate functions for timer 2:			
	1 2	2 3	40 41		T2 (P1.0): Timer/counter 2 external count input. T2EX (P1.1): Timer/counter 2 trigger input.			
P2.0-P2.7	21–28	24–31	18–25	1/0	Port 2: Port 2 is an 8-bit bidirectional I/O port with internal pull-ups. Port 2 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 2 pins that are externally being pulled low will source current because of the internal pull-ups. (See DC Electrical Characteristics: I <sub>IL</sub> ). Port 2 emits the high-order address byte during fetches from external program memory and during accesses to external data memory that use 16-bit addresses (MOVX @DPTR). In this application, it uses strong internal pull-ups when emitting 1s. During accesses to external data memory that use 8-bit addresses (MOV @Ri), port 2 emits the contents of the P2 special function register.			
P3.0-P3.7	10–17	11, 13–19	5, 7–13	1/0	<b>Port 3:</b> Port 3 is an 8-bit bidirectional I/O port with internal pull-ups. Port 3 pins that have 1s written to them are pulled high by the internal pull-ups and can be used as inputs. As inputs, port 3 pins that are externally being pulled low will source current because of the pull-ups. (See DC Electrical Characteristics: I <sub>IL</sub> ). Port 3 also serves the special features of the 80C51 family, as listed below:			
	10	11	5	1	RxD (P3.0): Serial input port			
	11	13	7 .	0	TxD (P3.1): Serial output port			
	12	14	8	1	INTO (P3.2): External interrupt			
	13	15	9	!	INT1 (P3.3): External interrupt			
[	14	16	10	!	To (P3.4): Timer 0 external input			
	15	17	11		T1 (P3.5): Timer 1 external input			
	16 17	18 19	12 13	0	WR (P3.6): External data memory write strobe			
			1	.	RD (P3.7): External data memory read strobe			
RST	9	10	4	1	<b>Reset:</b> A high on this pin for two machine cycles while the oscillator is running, resets the device. An internal diffused resistor to V <sub>SS</sub> permits a power-on reset using only an external capacitor to V <sub>CC</sub> .			
ALE/PROG	30	33	27	I/O	Address Latch Enable/Program Pulse: Output pulse for latching the low byte of the address during an access to external memory. In normal operation, ALE is emitted at a constant rate of 1/6 the oscillator frequency, and can be used for external timing or clocking. Note that one ALE pulse is skipped during each access to external data memory. This pin is also the program pulse input (PROG) during EPROM programming.			
PSEN	29	32	26	0	Program Store Enable: The read strobe to external program memory. When the device is executing code from the external program memory, PSEN is activated twice each machine cycle, except that two PSEN activations are skipped during each access to external data memory. PSEN is not activated during fetches from internal program memory.			
EA/V <sub>PP</sub>	31	35	29	l	External Access Enable/Programming Supply Voltage: EA must be externally held low to enable the device to fetch code from external program memory locations 0000H to 1FFFH. If EA is held high, the device executes from internal program memory unless the program counter contains an address greater than 1FFFH. This pin also receives the 12.75V programming supply voltage (V <sub>PP</sub> ) during EPROM programming.			
XTAL1	19	21	15	1	Crystal 1: Input to the inverting oscillator amplifier and input to the internal clock generator circuits.			
XTAL2	18	20	14	0	Crystal 2: Output from the inverting oscillator amplifier.			

### 80C32/80C52/87C52

#### **DIFFERENCES FROM THE 80C51**

### **Special Function Registers**

The special function register space is the same as the 80C51 except that the 80C52 contains the additional special function registers T2CON, RCAP2L, RCAP2H, TL2, and TH2. Since the standard 80C51 on-chip functions are identical in the 80C52, the SFR locations, bit locations, and operation are likewise identical. The only exceptions are in the interrupt mode and interrupt priority SFRs (see Table 1).

#### Timer/Counters

In addition to timer/counters 0 and 1 of the 80C51, the 80C52 contains timer/counter 2. Like timers 0 and 1, timer 2 can operate as either an event timer or as an event counter. This is selected by bit C/T2 in the special function register T2CON (see Figure 1). It has three operating modes: capture, auto-load, and baud rate generator, which are selected by bits in the T2CON as shown in Table 2.

In the Capture Mode there are two options which are selected by bit EXEN2 in T2CON. If EXEN2 = 0, then Timer 2 is a 16-bit timer or counter which upon overflowing sets bit TF2, the Timer 2 overflow bit, which can be used to generate an interrupt. If EXEN2 = 1, then Timer 2 still does the above, but with the added feature that a 1-to-0 transition at external input T2EX causes the current value

in the Timer 2 registers, TL2 and TH2, to be captured into registers RCAP2L and RCAP2H, respectively. (RCAP2L and RCAP2H are new special function registers in the 80C52.) In addition, the transition at T2EX causes bit EXF2 in T2CON to be set, and EXF2 like TF2 can generate an interrupt. The Capture Mode is illustrated in Figure 2.

In the auto-reload mode, there are again two options, which are selected by bit EXEN2 in T2CON. If EXEN2 = 0, then when Timer 2 rolls over it not only sets TF2 but also causes the Timer 2 registers to be reloaded with the 16-bit value in registers RCAP2L and RCAP2H, which are preset by software. If EXEN2 = 1, then Timer 2 still does the above, but with the added feature that a 1-to-0 transition at external input T2EX will also trigger the 16-bit reload and set EXF2. The auto-reload mode is illustrated in Figure 3.

The baud rate generation mode is selected by RCLK = 1 and/or TCLK = 1. It will be described in conjunction with the serial port.

#### **Serial Port**

The serial port of the 8XC52 is identical to that of the 80C51 except that counter/timer 2 can be used to generate baud rates.

In the 80C52, Timer 2 is selected as the baud rate generator by setting TCLK and/or RCLK in T2CON (see Figure 1). Note that the baud rate for transmit and receive can be simultaneously different. Setting RCLK and/or

TCLK puts Timer into its baud rate generator mode, as shown in Figure 4.

The baud rate generator mode is similar to the auto-reload mode, in that a rollover in TH2 causes the Timer 2 registers to be reloaded with the 16-bit value in registers RCAP2H and RCAP2L, which are preset by software

Now, the baud rates in Modes 1 and 3 are determined by Timer 2's overflow rate as follows:

Modes 1, 3
Baud Rate = Timer 2 Overflow Rate

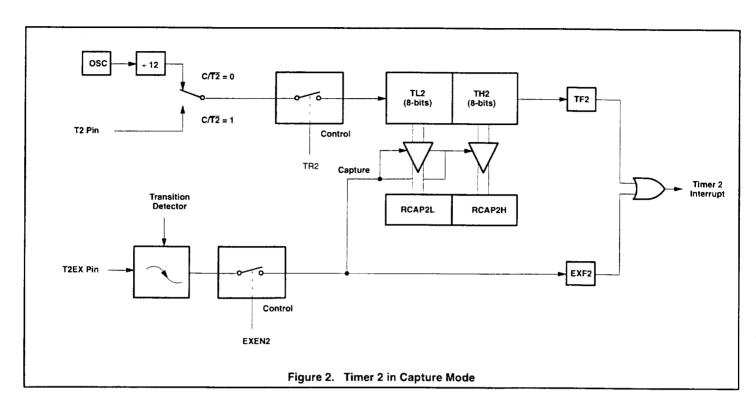
16

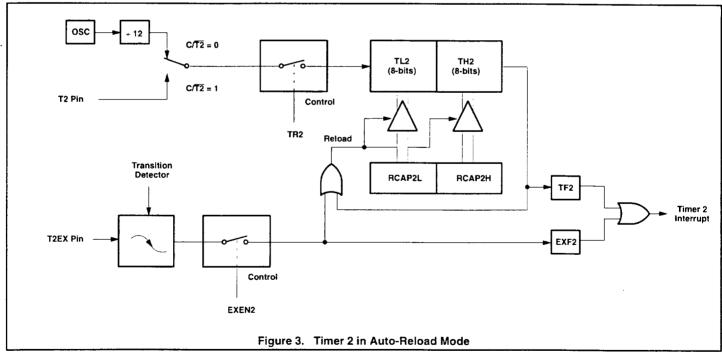
The timer can be configured for either "timer" or "counter" operation. In the most typical applications, it is configured for "timer" operation (C/T2 = 0). "Timer" operation is a little different for Timer 2 when it's being used as a baud rate generator. Normally, as a timer it would increment every machine cycle (thus at 1/12 the oscillator frequency). As a baud rate generator, however, it increments every state time (thus at 1/2 the oscillator frequency). In that case the baud rate is given by the formula:

Modes 1, 3
Baud Rate = Oscillator Frequency
32x[65536 – (RCAP2H, RCAP2L)]

where (RCAP2H, RCAP2L) is the content of RCAP2H and RCAP2L taken as a 16-bit unsigned integer.

	(MSB)						,	(LSB)	
	TF2	EXF2	RCLK	TCLK	EXEN2	TR2	C/T2	CP/RL2	
Symbol	Position			N	lame and S	Significan	ce		
TF2	T2CON.7	Tim eith	er 2 overfl er RCLK o	ow flag set r TCLK = 1	by a Timer	2 overflow	and must	be cleared	by software. TF2 will not be set when
EXF2	T2CON.6	E /	er 2 exterr EN2 = 1, W errupt routir	nen rimer	2 interrupt	is enabled	I. EXF2 = 1	is caused by will cause	y a negative transition on T2EX and the CPU to vector to the Timer 2
RCLK	T2CON.5	Red	ceive clock des 1 and 3	flag. Wher 3. RCLK =	set, cause 0 causes T	es the seria	Il port to us	e Timer 2 o used for the	verflow pulses for its receive clock in a receive clock.
TCLK	T2CON.4	Tra mo	nsmit clock des 1 and 3	flag. When	n set, cause Causes Ti	es the seri mer 1 ove	al port to u	se Timer 2 o	overflow pulses for its transmit clock in transmit clock.
EXEN2	T2CON.3	trar	er 2 extern sition on T ore events	2EX II IImi	lag. When : er 2 is not b	set, allows being used	a capture to clock th	or reload to e serial port	occur as a result of a negative EXEN2 = 0 causes Timer 2 to
TR2	T2CON.2	Sta	rt/stop cont	roi for Time	er 2. A logic	1 starts th	ne timer.		
C/T2	T2CON.1	Tim		ai timer (O		ng edge tri	ggered).		
CP/AL2	T2CON.0	= 1.	trea, auto-r	eloads will	occur eithe	er with Time	er 2 overflo	ws or nega	itions at T2EX if EXEN2 = 1. When tive transitions at T2EX when EXEN; ner is forced to auto-reload on Timer





### 80C32/80C52/87C52

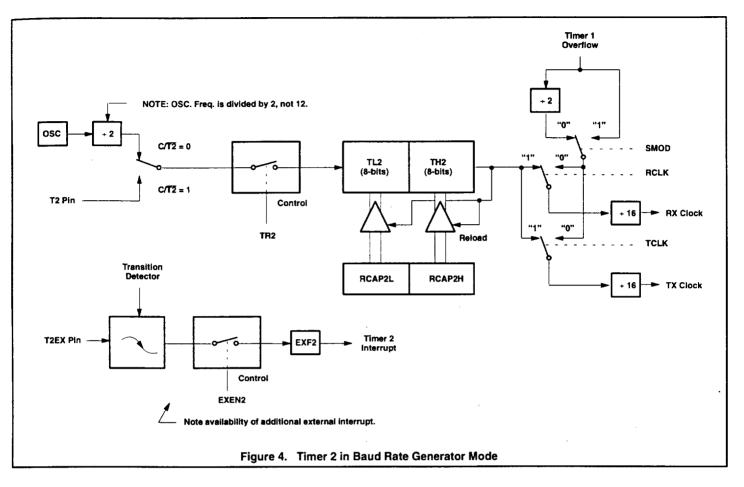


Table 2. Timer 2 Operating Modes

RCLK + RCLK	CP/RL2	TR2	MODE
0	0	1	16-bit Auto-reload
0	1	1	16-bit Capture
1	X	1	Baud rate generator
X	X	0	(off)

Timer 2 as a baud rate generator is shown in Figure 4. This figure is valid only if RCLK + TCLK = 1 in T2CON. Note that a rollover in TH2 does not set TF2, and will not generate an interrupt. Therefore, the Timer 2 interrupt does not have to be disabled when Timer 2 is in the baud rate generator mode. Note too, that if EXEN2 is set, a 1-to-0 transition in T2EX will set EXF2 but will not cause a reload from (RCAP2H, RCAP2L) to (TH2, TL2). Thus when Timer 2 is in use as a baud rate generator, T2EX can be used as an extra external interrupt, if desired.

It should be noted that when Timer 2 is running (TR2 = 1) in "timer" function in the baud rate generator mode, one should not try to read or write TH2 or TL2. Under these conditions the timer is being incremented

every state time, and the results of a read or write may not be accurate. The RCAP registers may be read, but should not be written to, because a write might overlap a reload and cause write and/or reload errors. Turn the timer off (clear TR2) before accessing the Timer 2 or RCAP registers, in this case.

#### Timer/Counter 2 Set-up

Except for the baud rate generator mode, the values given for T2CON do not include the setting of the TR2 bit. Therefore, bit TR2 must be set, separately, to turn the timer on. See Table 3 for set-up of timer 2 as a timer. See Table 4 for set-up of timer 2 as a counter.

#### Using Timer/Counter 2 to Generate Baud Rates

For this purpose, Timer 2 must be used in the baud rate generating mode. If Timer 2 is being clocked through pin T2 (P1.0) the baud rate is:

And if it is being clocked internally, the baud rate is:

Baud Rate = 
$$\frac{\text{Oscillator Frequency}}{32x[65536 - (RCAP2H, RCA2PL)]}$$

To obtain the reload value for RCAP2H and RCA02L, the above equation can be rewritten as:

RCAP2H, 
$$= 65536 - \frac{Oscillator Frequency}{32 \times Baud Rate}$$

### 80C32/80C52/87C52

#### Interrupts

The 80C52 has 6 interrupt sources. All except TF2 and EXF2 are identical sources to those in the 80C51.

The Interrupt Enable Register and the Interrupt Priority Register are modified to include the additional 80C52 interrupt sources. The operation of these registers is identical to the 80C51.

In the 80C52, the Timer 2 Interrupt is generated by the logical OR of TF2 and EXF2. Neither of these flags is cleared by hardware when the service routine is

vectored to. In fact, the service routine may have to determine whether it was TF2 or EXF2 that generated the interrupt, and the bit will have to be cleared in software.

All of the bits that generate interrupts can be set or cleared by software, with the same result as though it has been set or cleared by hardware. That is, interrupts can be generated or pending interrupts can be canceled in software.

The interrupt vector addresses and the interrupt priority for requests in the same priority level are given in the following:

Source	Vector Address	Priority Within Level
4 150		
1. IE0	0003H	(highest)
2. TF0	000BH	
3. IE1	0013H	
4. TF1	001BH	
5. RI + TI	0023H	
6. TF2 + EXF2	002BH	(lowest)

Note that they are identical to those in the 80C51 except for the addition of the Timer 2 (TF1 and EXF2) interrupt at 002BH and at the lowest priority within a level.

Table 3. Timer 2 as a Timer

MODE	T2CON			
	INTERNAL CONTROL (Note 1)	EXTERNAL CONTROL (Note 2)		
16-bit Auto-Reload	00Н	08H		
16-bit Capture	01H	09H		
Baud rate generator receive and transmit same baud rate	34H	36H		
Receive only	24H	26H		
Transmit only	14H	16H		

#### Table 4. Timer 2 as a Counter

MODE	TMOD			
	INTERNAL CONTROL (Note 1)	EXTERNAL CONTROL (Note 2)		
16-bit	02H	0AH		
Auto-Reload	03H	0BH		

- 1. Capture/reload occurs only on timer/counter overflow.
- Capture/reload occurs on timer/counter overflow and a 1-to-0 transition on T2EX (P1.1) pin except when timer 2 is used in the baud rate generator mode.

### 80C32/80C52/87C52

## OSCILLATOR CHARACTERISTICS

XTAL1 and XTAL2 are the input and output, respectively, of an inverting amplifier. The pins can be configured for use as an on-chip oscillator, as shown in the Logic Symbol, page 285.

To drive the device from an external clock source, XTAL1 should be driven while XTAL2 is left unconnected. There are no requirements on the duty cycle of the external clock signal, because the input to the internal clock circuitry is through a divide-by-two flip-flop. However, minimum and maximum high and low times specified in the data sheet must be observed.

#### RESET

A reset is accomplished by holding the RST pin high for at least two machine cycles (24

oscillator periods), while the oscillator is running. To insure a good power-up reset, the RST pin must be high long enough to allow the oscillator time to start up (normally a few milliseconds) plus two machine cycles.

#### **IDLE MODE**

In idle mode, the CPU puts itself to sleep while all of the on-chip peripherals stay active. The instruction to invoke the idle mode is the last instruction executed in the normal operating mode before the idle mode is activated. The CPU contents, the on-chip RAM, and all of the special function registers remain intact during this mode. The idle mode can be terminated either by any enabled interrupt (at which time the process is picked up at the interrupt service routine and continued), or by a hardware reset which starts the processor in the same manner as a power-on reset.

#### **POWER-DOWN MODE**

In the power-down mode, the oscillator is stopped and the instruction to invoke power-down is the last instruction executed. Only the contents of the on-chip RAM are preserved. A hardware reset is the only way to terminate the power-down mode, the control bits for the reduced power modes are in the special function register PCON.

#### **DESIGN CONSIDERATIONS**

At power-on, the voltage on  $V_{\rm CC}$  and RST must come up at the same time for a proper start-up.

Table 5 shows the state of I/O ports during low current operating modes.

#### **ROM CODE SUBMISSION**

When submitting ROM code for the 80C52, the following must be specified:

- 1. 8k byte user ROM data
- 2. 32 byte ROM encryption key
- 3. ROM security bits.

ADDRESS	CONTENT	BIT(S)	COMMENT
0000H to 1FFFH	DATA	7:0	User ROM Data
2000H to 201FH	KEY	7:0	ROM Encryption Key FFH = no encryption
2020H	SEC	0	ROM Security Bit 1
2020H	SEC	1	ROM Security Bit 2 0 = enable security 1 = disable security

Security Bit 1: When programmed, this bit has two effects on masked ROM parts:

- 1. External MOVC is disabled, and
- 2. EA# is latched on Reset.

Security Bit 2: When programmed, this bit inhibits Verify User ROM.

Table 5. External Pin Status During Idle and Power-Down Modes

MODE	PROGRAM MEMORY	ALE	PSEN	PORT 0	PORT 1	PORT 2	PORT 3
ldle	Internal	1	1	Data	Data	Data	Data
Idle	External	1	1	Float	Data	Address	Data
Power-down	Internal	0	0	Data	Data	Data	Data
Power-down	External	0	0	Float	Data	Data	Data

### 80C32/80C52/87C52

Electrical Deviations from Commercial Specifications for Extended Temperature Range (87C52)

DC and AC parameters not included here are the same as in the commercial temperature range table.

#### DC ELECTRICAL CHARACTERISTICS

 $T_{amb} = -40$ °C to +85°C,  $V_{CC} = 5V \pm 10$ %,  $V_{SS} = 0V$ 

		TEST	LIN		
SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V <sub>IL</sub>	Input low voltage, except EA		-0.5	0.2V <sub>CC</sub> -0.15	V
V <sub>IL1</sub>	Input low voltage to EA		0	0.2V <sub>CC</sub> -0.35	V
V <sub>IH</sub>	Input high voltage, except XTAL1, RST		0.2V <sub>CC</sub> +1	V <sub>CC</sub> +0.5	V
V <sub>IH1</sub>	Input high voltage to XTAL1, RST		0.7V <sub>CC</sub> +0.1	V <sub>CC</sub> +0.5	V
I <sub>IL</sub>	Logical 0 input current, ports 1, 2, 3	V <sub>IN</sub> = 0.45V		-75	μА
I <sub>TL</sub>	Logical 1-to-0 transition current, ports 1, 2, 3	V <sub>IN</sub> = 2.0V		-750	μА
<sup>l</sup> cc	Power supply current: Active mode Idle mode Power-down mode	V <sub>CC</sub> = 4.5–5.5V, Frequency range = 3.5 to 16MHz		19 6 50	mA mA μA

#### **ABSOLUTE MAXIMUM RATINGS** 1, 2, 3

PARAMETER	RATING	UNIT	
Operating temperature under bias	0 to +70 or -40 to +85	°C	
Storage temperature range	-65 to +150	°C	
Voltage on EA/V <sub>PP</sub> pin to V <sub>SS</sub>	0 to +13.0	V	
Voltage on any other pin to V <sub>SS</sub>	-0.5 to +6.5	V	
Maximum I <sub>OL</sub> per I/O pin	15	mA	
Power dissipation (based on package heat transfer limitations, not device power consumption)	1.5	W	

#### NOTES:

- Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any conditions other than those described in the AC and DC Electrical Characteristics section of this specification is not implied.
- 2. This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maxima.
- Parameters are valid over operating temperature range unless otherwise specified. All voltages are with respect to V<sub>SS</sub> unless otherwise noted.

### 80C32/80C52/87C52

#### DC ELECTRICAL CHARACTERISTICS

 $T_{amb} = 0^{\circ}C$  to +70°C or -40°C to +85°C,  $V_{CC} = 5V \pm 10\%$ ,  $V_{SS} = 0V$  (87C52)

 $T_{amb} = 0^{\circ}\text{C to } +70^{\circ}\text{C or } -40^{\circ}\text{C to } +85^{\circ}\text{C}, V_{CC} = 5\text{V} \pm 20^{\circ}, V_{SS} = 0\text{V} (80\text{C}32/80\text{C}52)$ 

SYMBOL		TEST	LIMITS			
	PARAMETER	CONDITIONS	MIN	TYP <sup>1</sup>	MAX	UNIT
V <sub>IL</sub>	Input low voltage, except EA <sup>7</sup>		-0.5		0.2V <sub>CC</sub> -0.1	٧
V <sub>IL1</sub>	Input low voltage to EA <sup>7</sup>		0		0.2V <sub>CC</sub> -0.3	٧
V <sub>IH</sub>	Input high voltage, except XTAL1, RST <sup>7</sup>		0.2V <sub>CC</sub> +0.		V <sub>CC</sub> +0.5	٧
V <sub>IH1</sub>	Input high voltage, XTAL1, RST <sup>7</sup>		0.7V <sub>CC</sub>		V <sub>CC</sub> +0.5	٧
V <sub>OL</sub>	Output low voltage, ports 1, 2, 3 <sup>9</sup>	$I_{OL} = 1.6 \text{mA}^2$			0.45	V
V <sub>OL1</sub>	Output low voltage, port 0, ALE, PSEN9	$I_{OL} = 3.2 \text{mA}^2$		-	0.45	٧
V <sub>OH</sub>	Output high voltage, ports 1, 2, 3, ALE, PSEN <sup>3</sup>	l <sub>OH</sub> = -60μA, l <sub>OH</sub> = -25μA l <sub>OH</sub> = -10μA	2.4 0.75V <sub>CC</sub> 0.9V <sub>CC</sub>			V V V
V <sub>OH1</sub>	Output high voltage (port 0 in external bus mode)	I <sub>OH</sub> = -800μA, I <sub>OH</sub> = -300μA I <sub>OH</sub> = -80μA	2.4 0.75V <sub>CC</sub> 0.9V <sub>CC</sub>			V V V
I <sub>IL</sub>	Logical 0 input current, ports 1, 2, 3 <sup>7</sup>	V <sub>IN</sub> = 0.45V			-50	μА
I <sub>TL</sub>	Logical 1-to-0 transition current, ports 1, 2, 3 <sup>7</sup>	See note 4			-650	μА
ILI	Input leakage current, port 0	$V_{IN} = V_{IL} \text{ or } V_{IH}$			±10	μА
lcc	Power supply current: <sup>7</sup> Active mode @ 12MHz <sup>5</sup> Idle mode @ 12MHz Power-down mode	See note 6		11.5 1.3 3	19 4 50	mA mA μA
R <sub>RST</sub>	Internal reset pull-down resistor		50		300	kΩ
C <sub>IO</sub>	Pin capacitance				10	pF

#### NOTES:

- 1. Typical ratings are not guaranteed. The values listed are at room temperature, 5V.
- 2. Capacitive loading on ports 0 and 2 may cause spurious noise to be superimposed on the Vols of ALE and ports 1 and 3. The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operations. In the worst cases (capacitive loading > 100pF), the noise pulse on the ALE pin may exceed 0.8V. In such cases, it may be desirable to qualify ALE with a Schmitt Trigger, or use an address latch with a Schmitt Trigger STROBE input. IOL can exceed these conditions provided that no single output sinks more than 5mA and no more than two outputs exceed the test conditions.
- 3. Capacitive loading on ports 0 and 2 may cause the VOH on ALE and PSEN to momentarily fall below the 0.9V<sub>CC</sub> specification when the address bits are stabilizing.
- 4. Pins of ports 1, 2 and 3 source a transition current when they are being externally driven from 1 to 0. The transition current reaches its maximum value when VIN is approximately 2V.
- 5. I<sub>CCMAX</sub> at other frequencies is given by: Active mode: I<sub>CCMAX</sub> = 1.43 X FREQ + 1.9: Idle mode: I<sub>CCMAX</sub> = 0.14 X FREQ +2.31, where FREQ is the external oscillator frequency in MHz. ICCMAX is given in mA. See Figure 12.
- 6. See Figures 13 through 16 for I<sub>CC</sub> test conditions.
- 7. These values apply only to  $T_{amb} = 0^{\circ}C$  to  $+70^{\circ}C$ . For  $T_{amb} = -40^{\circ}C$  to  $+85^{\circ}C$ , see table on previous page.
- 8. Load capacitance for port 0, ALE, and PSEN = 100pF, load capacitance for all other outputs = 80pF.
- 9. Under steady state (non-transient) conditions, IOL must be externally limited as follows:

Maximum IOL per port pin:

15mA (\*NOTE: This is 85°C specification.)

Maximum IOL per 8-bit port:

26mA

Maximum total IOL for all outputs:

If IoL exceeds the test condition, Vol. may exceed the related specification. Pins are not guaranteed to sink current greater than the listed test conditions.

### 80C32/80C52/87C52

#### **AC ELECTRICAL CHARACTERISTICS**

 $T_{amb} = 0^{\circ}C$  to +70°C or -40°C to +85°C,  $V_{CC} = 5V \pm 10\%$ ,  $V_{SS} = 0V (87C52)^{1, 2, 3}$ 

			24MHz CLOCK		VARIABLE CLOCK		
SYMBOL 1/t <sub>CLCL</sub>	FIGURE 5	PARAMETER	MIN MAX		MIN	MAX	UNIT
		Oscillator frequency: Speed Versions 8XC52 E			3.5	16	MHz
		8XC52			3.5	24	MHz
tLHLL	5	ALE pulse width	43		2t <sub>CLCL</sub> -40		ns
t <sub>AVLL</sub>	5	Address valid to ALE low	28		t <sub>CLCL</sub> -13		ns
tLLAX	5	Address hold after ALE low	21		t <sub>CLCL</sub> -20		ns
t <sub>LLIV</sub>	5	ALE low to valid instruction in		101		4t <sub>CLCL</sub> -65	ns
t <sub>LLPL</sub>	5	ALE low to PSEN low	28		t <sub>CLCL</sub> -13		ns
t <sub>PLPH</sub>	5	PSEN pulse width	104		3t <sub>CLCL</sub> -20		ns
t <sub>PLIV</sub>	5	PSEN low to valid instruction in		79		3t <sub>CLCL</sub> -45	ns
t <sub>PXIX</sub>	5	Input instruction hold after PSEN	0		0		ns
t <sub>PXIZ</sub>	5	Input instruction float after PSEN		31		t <sub>CLCL</sub> -10	ns
t <sub>AVIV</sub>	5	Address to valid instruction in		153		5t <sub>CLCL</sub> -55	ns
t <sub>PLAZ</sub>	5 -	PSEN low to address float		10		10	ns
Data Mem	ory		<b>.</b>	<u> </u>			·
t <sub>RLRH</sub>	6, 7	RD pulse width	149		6t <sub>CLCL</sub> -100		ns
twwh	6, 7	WR pulse width	149	<del></del>	6t <sub>CLCL</sub> -100		ns
t <sub>RLDV</sub>	6, 7	RD low to valid data in		118		5t <sub>CLCL</sub> -90	ns
t <sub>RHDX</sub>	6, 7	Data hold after RD	0		0		ns
t <sub>RHDZ</sub>	6, 7	Data float after RD		55		2t <sub>CLCL</sub> -28	ns
t <sub>LLDV</sub>	6, 7	ALE low to valid data in	<b>†</b>	183		8t <sub>CLCL</sub> -150	ns
t <sub>AVDV</sub>	6, 7	Address to valid data in		209		9t <sub>CLCL</sub> -165	ns
t <sub>LLWL</sub>	6, 7	ALE low to RD or WR low	74	174	3t <sub>CLCL</sub> -50	3t <sub>CLCL</sub> +50	ns
t <sub>AVWL</sub>	6, 7	Address valid to WR low or RD low	91		4t <sub>CLCL</sub> -75		ns
tovwx	6, 7	Data valid to WR transition	21		t <sub>CLCL</sub> -20		ns
twhax	6, 7	Data hold after WR	21		t <sub>CLCL</sub> -20		ns
t <sub>RLAZ</sub>	6, 7	RD low to address float		0		0	ns
twhLH	6, 7	RD or WR high to ALE high	21	66	t <sub>CLCL</sub> -20	t <sub>CLCL</sub> +25	ns
External C	lock			1	.1		<u> </u>
tchcx	9	High time	20		20		ns
tclcx	9	Low time	20		20		ns
t <sub>CLCH</sub>	9	Rise time		20		20	ns
tCHCL	9	Fall time		20	1	20	ns
Shift Regi			<del></del>	I	1		
†XLXL	8	Serial port clock cycle time	499	Ī	12t <sub>CLCL</sub>	<u> </u>	ns
tovxh	8	Output data setup to clock rising edge	283		10t <sub>CLCL</sub> -133		ns
txHqx	8	Output data hold after clock rising edge	3	<del> </del>	2t <sub>CLCL</sub> -80		ns
t <sub>XHDX</sub>	8	Input data hold after clock rising edge	0		0		ns
t <sub>XHDV</sub>	8	Clock rising edge to input data valid	<del>                                     </del>	283	1	10t <sub>CLCL</sub> -133	ns

#### NOTES:

- 1. Parameters are valid over operating temperature range unless otherwise specified.
- 2. Load capacitance for port 0, ALE, and PSEN = 100pF, load capacitance for all other outputs = 80pF.
- 3. Interfacing the 80C32/52 to devices with float times up to 45ns is permitted. This limited bus contention will not cause damage to Port 0 drivers.

### 80C32/80C52/87C52

#### **EXPLANATION OF THE AC SYMBOLS**

Each timing symbol has five characters. The first character is always 't' (= time). The other characters, depending on their positions, indicate the name of a signal or the logical status of that signal. The designations are:

A - Address

C - Clock

D - Input data

H - Logic level high

I – Instruction (program memory contents)

L - Logic level low, or ALE

P - PSEN

Q - Output data

R - RD signal

t - Time

V - Valid

W- WR signal

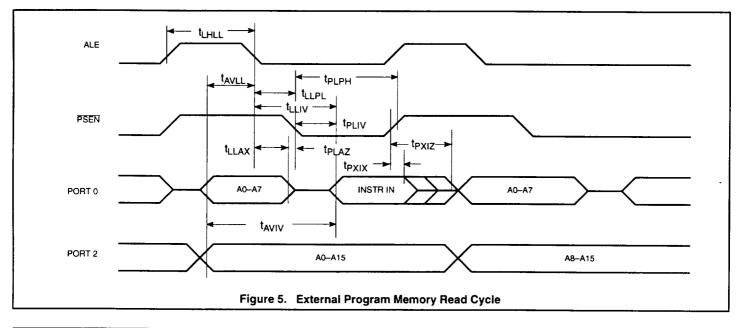
X - No longer a valid logic level

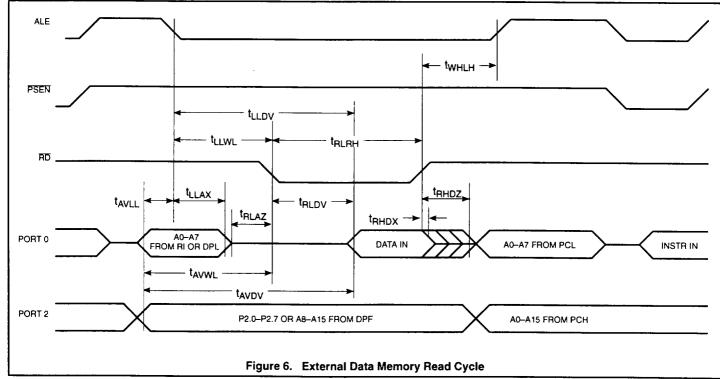
Z - Float

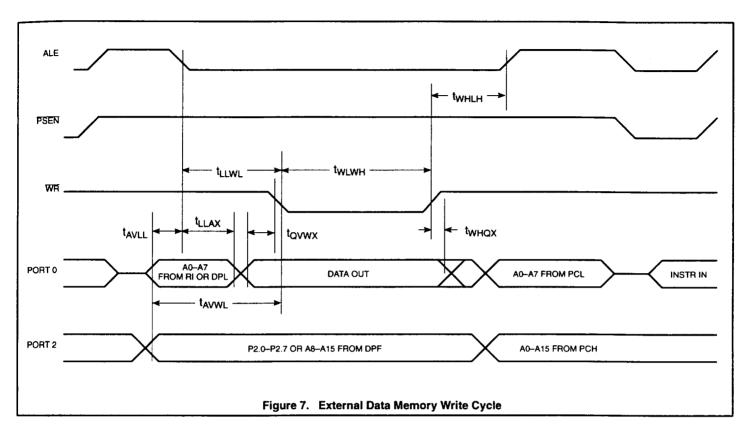
Examples: t<sub>AVLL</sub> = Time for address valid to

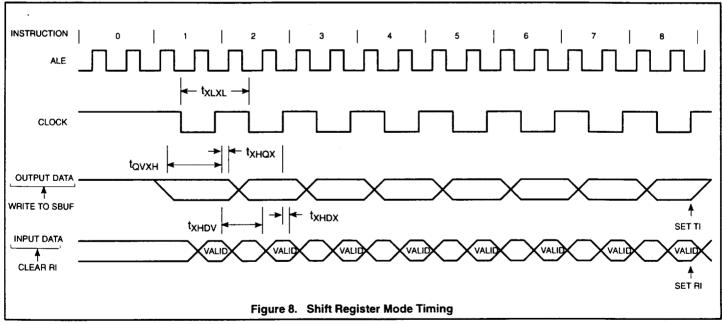
ALE low.

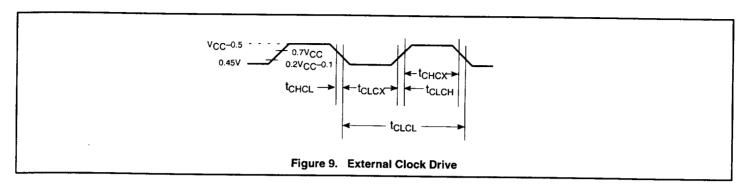
t<sub>LLPL</sub>= Time for ALE low to PSEN low.

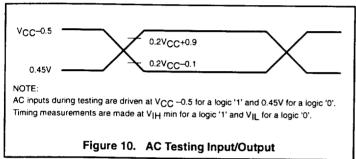


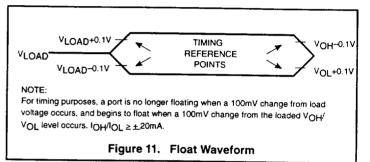


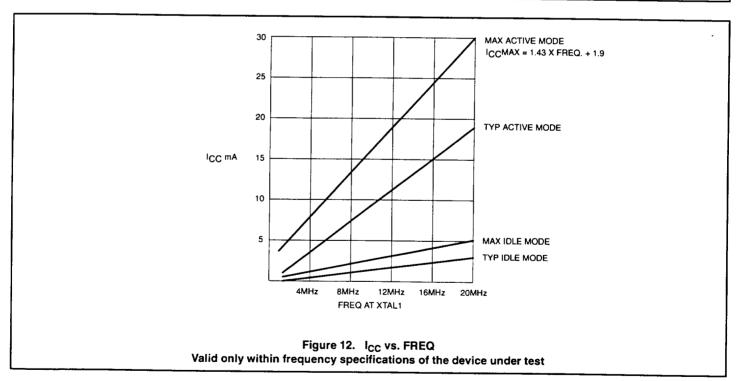


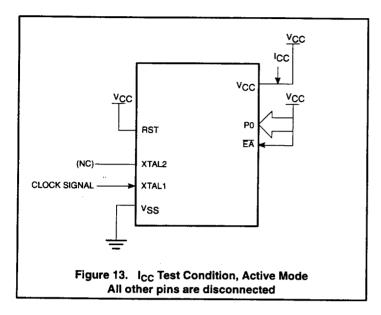


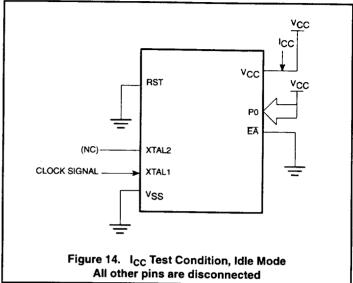


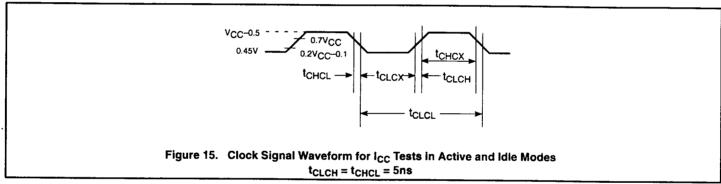


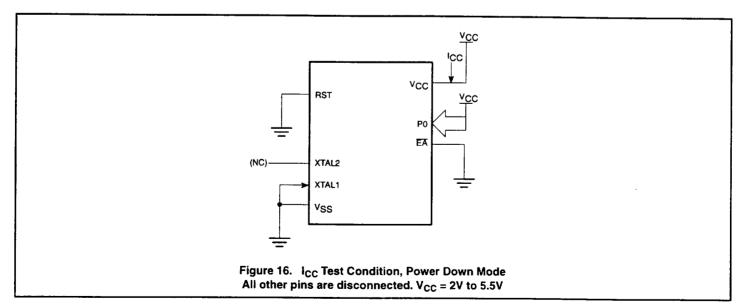












### 80C32/80C52/87C52

#### **EPROM CHARACTERISTICS**

The 87C52 is programmed by using a modified Quick-Pulse Programming™ algorithm. It differs from older methods in the value used for V<sub>PP</sub> (programming supply voltage) and in the width and number of the ALE/PROG pulses.

The 87C52 contains two signature bytes that can be read and used by an EPROM programming system to identify the device. The signature bytes identify the device as an 87C52 manufactured by Philips.

Table 6 shows the logic levels for reading the signature byte, and for programming the program memory, the encryption table, and the security bits. The circuit configuration and waveforms for quick-pulse programming are shown in Figures 17 and 18. Figure 19 shows the circuit configuration for normal program memory verification.

#### **Quick-Pulse Programming**

The setup for microcontroller quick-pulse programming is shown in Figure 17. Note that the 87C52 is running with a 4 to 6MHz oscillator. The reason the oscillator needs to be running is that the device is executing internal address and program data transfers.

The address of the EPROM location to be programmed is applied to ports 1 and 2, as shown in Figure 17. The code byte to be programmed into that location is applied to port 0. RST, PSEN and pins of ports 2 and 3 specified in Table 6 are held at the 'Program Code Data' levels indicated in Table 6. The ALE/PROG is pulsed low 25 times as shown in Figure 18.

To program the encryption table, repeat the 25 pulse programming sequence for addresses 0 through 1FH, using the 'Pgm Encryption Table' levels. Do not forget that after the encryption table is programmed, verification cycles will produce only encrypted data.

To program the security bits, repeat the 25 pulse programming sequence using the 'Pgm Security Bit' levels. After one security bit is programmed, further programming of the code memory and encryption table is disabled. However, the other security bit can still be programmed.

Note that the EA/V<sub>PP</sub> pin must not be allowed to go above the maximum specified V<sub>PP</sub> level for any amount of time. Even a narrow glitch above that voltage can cause permanent damage to the device. The V<sub>PP</sub> source should be well regulated and free of glitches and overshoot.

#### **Program Verification**

If security bit 2 has not been programmed, the on-chip program memory can be read out for program verification. The address of the program memory locations to be read is applied to ports 1 and 2 as shown in Figure 19. The other pins are held at the 'Verify Code Data' levels indicated in Table 6. The contents of the address location will be emitted on port 0. External pull-ups are required on port 0 for this operation.

If the encryption table has been programmed, the data presented at port 0 will be the exclusive NOR of the program byte with one of the encryption bytes. The user will have to know the encryption table contents in order to correctly decode the verification data. The encryption table itself cannot be read out.

#### **Reading the Signature Bytes**

The signature bytes are read by the same procedure as a normal verification of locations 030H and 031H, except that P3.6 and P3.7 need to be pulled to a logic low. The values are:

(030H) = 15H indicates manufactured by Philips

(031H) = 97H indicates 87C52

### **Program/Verify Algorithms**

Any algorithm in agreement with the conditions listed in Table 6, and which satisfies the timing specifications, is suitable.

#### **Erasure Characteristics**

Erasure of the EPROM begins to occur when the chip is exposed to light with wavelengths shorter than approximately 4,000 angstroms. Since sunlight and fluorescent lighting have wavelengths in this range, exposure to these light sources over an extended time (about 1 week in sunlight, or 3 years in room level fluorescent lighting) could cause inadvertent erasure. For this and secondary effects, it is recommended that an opaque label be placed over the window. For elevated temperature or environments where solvents are being used, apply Kapton tape Fluorglas part number 2345–5, or equivalent.

The recommended erasure procedure is exposure to ultraviolet light (at 2537 angstroms) to an integrated dose of at least 15W-s/cm². Exposing the EPROM to an ultraviolet lamp of 12,000µW/cm² rating for 20 to 39 minutes, at a distance of about 1 inch, should be sufficient.

Erasure leaves the array in an all 1s state.

**Table 6. EPROM Programming Modes** 

MODE	RST	PSEN	ALE/PROG	EA/V <sub>PP</sub>	P2.7	P2.6	P3.7	P3.6
Read signature	1	0	1	1	0	0	0	0
Program code data	1	0	0*	V <sub>PP</sub>	1	0	1	1
Verify code data	1	0	1	1	0	0	1	1
Pgm encryption table	1	0	0*	$V_{PP}$	1	0	1	0
Pgm security bit 1	1	0	0*	V <sub>PP</sub>	1	1	1	1
Pgm security bit 2	1	0	0*	V <sub>PP</sub>	1	1	0	0

#### NOTES:

- 1. '0' = Valid low for that pin, '1' = valid high for that pin.
- 2.  $V_{PP} = 12.75V \pm 0.25V$ .
- 3.  $V_{CC} = 5V \pm 10\%$  during programming and verification.
- \*ALE/PROG receives 25 programming pulses while V<sub>PP</sub> is held at 12.75V. Each programming pulse is low for 100μs (±10μs) and high for a minimum of 10μs.

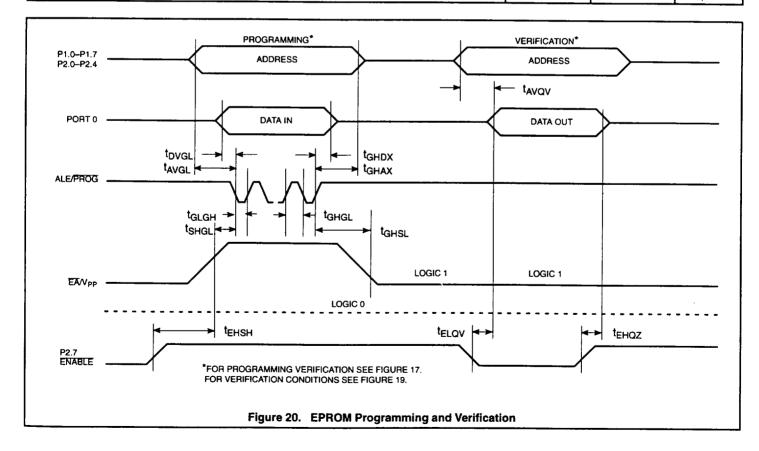
<sup>™</sup>Trademark phrase of Intel Corporation.

### 80C32/80C52/87C52

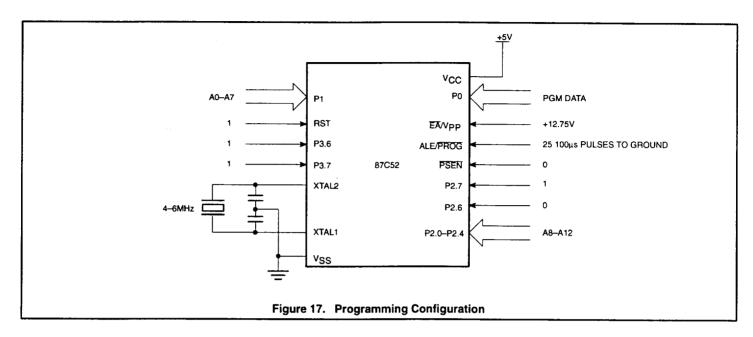
### **EPROM PROGRAMMING AND VERIFICATION CHARACTERISTICS**

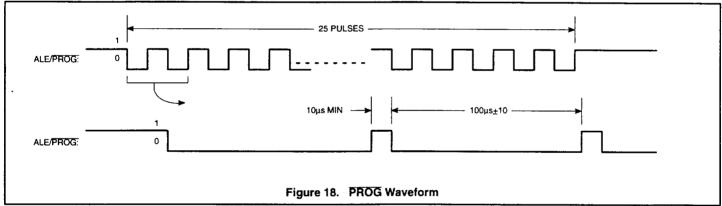
 $T_{amb} = 21^{\circ}C \text{ to } +27^{\circ}C, V_{CC} = 5V\pm10\%, V_{SS} = 0V \text{ (See Figure 20)}$ 

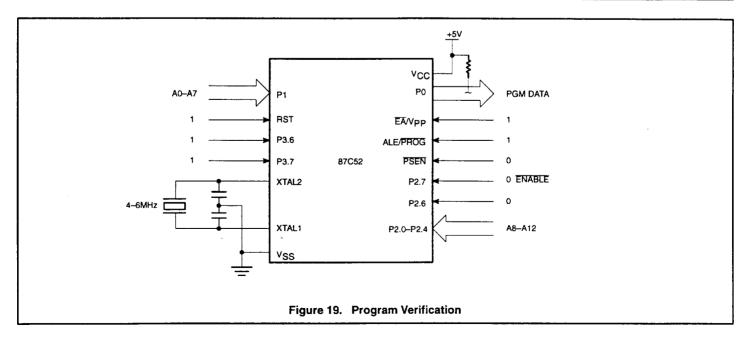
SYMBOL	PARAMETER	MIN	MAX	UNIT
V <sub>PP</sub>	Programming supply voltage	12.5	13.0	V
lpp	Programming supply current		50	mA
1/t <sub>CLCL</sub>	Oscillator frequency	4	6	MHz
t <sub>AVGL</sub>	Address setup to PROG low	48t <sub>CLCL</sub>		
<sup>t</sup> GHAX	Address hold after PROG	48t <sub>CLCL</sub>		
<sup>t</sup> DVGL	Data setup to PROG low	48t <sub>CLCL</sub>		
<sup>t</sup> GHDX	Data hold after PROG	48t <sub>CLCL</sub>		
t <sub>EHSH</sub>	P2.7 (ENABLE) high to V <sub>PP</sub>	48t <sub>CLCL</sub>		
<sup>t</sup> shgL	V <sub>PP</sub> setup to PROG low	10	-	μѕ
t <sub>GHSL</sub>	V <sub>PP</sub> hold after PROG	10		μs
<sup>t</sup> GLGH	PROG width	90	110	μs
t <sub>avqv</sub>	Address to data valid		48t <sub>CLCL</sub>	
t <sub>ELQZ</sub>	ENABLE low to data valid		48t <sub>CLCL</sub>	
t <sub>EHQZ</sub>	Data float after ENABLE	0	48t <sub>CLCL</sub>	
t <sub>GHGL</sub>	PROG high to PROG low	10		μs



### 80C32/80C52/87C52







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